

**Issue Classification**

Application/Control No.

10698666

Applicant(s)/Patent Under Reexamination

HUSTED, PAUL J.

Examiner

Lee, Siu M.

Art Unit

2611

**ORIGINAL**

CLASS

SUBCLASS

375

316

**CROSS REFERENCE(S)**

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

375

341

262

340

260

368

455

219

232.1

234.1

234.2

226.1

**INTERNATIONAL CLASSIFICATION**

CLAIMED

NON-CLAIMED

H

O

4

L

27 / 00 (2006.01.01)

Lee, Siu M

2/13/2008

(Assistant Examiner)

(Date)

Total Claims Allowed:

21

(Legal Instruments  
Examiner)

(Date)

CHIEH M. FAN  
SUPERVISORY PATENT EXAMINER  
(Primary Examiner)

O.G. Print Claim(s)

1

O.G. Print Figure

4